Probing the spin-glass freezing transition in $Cu_{1-x}Mn_x$ alloy by spin current

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In this study, we used the thermally driven spin current to investigate the spin frustrations and spin fluctuations in spin-glass (SG) $Cu_{1-x}Mn_x$ alloys. Tuning the $Cu_{1-x}Mn_x$ composition results in a transition of the alloys from the SG state to the antiferromagnetic state; these states have different spin-freezing temperatures (T_f) . Most spins randomly freeze at temperatures lower than the T_f of the alloy. For each alloy composition, we obtained a temperature-dependent inverse spin Hall voltage with a peak at T_p . Crucially, T_p had nearly identical composition dependence as that of T_f , with T_p being nine times larger than T_f . Similar behavior was captured using the SG insulator, amorphous $Y_3Fe_5O_{12}$. These results indicated that the maximum spin fluctuation in both conducting and insulating SGs occurred at temperatures considerably higher than the T_f of each. In addition, we demonstrated the importance of the effective number of valence electrons in tailoring the spin Hall angle in binary alloys.

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I. INTRODUCTION

The exploitation of pure spin current with a flow of spin angular momentum is a promising alternative to traditional charged-based electronic devices to keep pace with Moore's law. Numerous studies have focused on the efficient generation and manipulation of spin current for spintronic devices. An effective approach to enhance the spin current is through spin fluctuations (SFs) [1,2]. During magnetic phase transition, magnetic systems evolve from the long-range ordered magnetic state into the disordered state and exhibit shortrange SFs. Several researchers have demonstrated an increase in the spin current near the phase transition temperature in magnetic systems such as the weak ferromagnetic (FM) metal NiPd [3]; the antiferromagnetic (AFM) insulators NiO [4,5], CoO [6], and Cr_2O_3 [7]; the AFM metal IrMn [8,9]; and the FM alloy Fe_xPt_{1-x} [10]. Spin-current enhancement in these long-range ordered magnetic systems during SF suggests that the short-range ordered spin-glass (SG) system can possibly be enhanced because the frustrated intrachain coupling in SG has a significant short-range order that induces large fluctuations [11].

In SG materials, magnetic ions are randomly distributed among the host nonmagnets. When cooled from the paramagnetic state, the SG materials exhibit a nontrivial spinfreezing transition, where spins start to align in random directions and slowly reach a glassy state. Injecting spin current into SG materials has been previously studied using FMresonance-driven spin pumping [12] and nonlocal spin valve [13] measurements. However, the results were contradictory with the strong enhancement observed in spin pumping and the strong suppression observed in nonlocal spin valve measurements.

To understand the interplay between spin current and SG systems, we studied the temperature dependence of the injection of spin current from the FM insulator Y₃Fe₅O₁₂ (YIG) into SG $Cu_{1-x}Mn_x$ alloys with various compositions and under a range of temperatures including their phase transitions. $Cu_{1-x}Mn_x$ alloys possess rich magnetic phases, as depicted in Fig. 1(a). When the concentration of Mn increases, its magnetic phase changes from SG to AFM. By measuring zero-field-cooled (ZFC) and field-cooled (FC) magnetization, we obtained the spin-freezing temperature (T_f) , the temperature at which the ZFC and FC curves bifurcate and exhibit irreversible behavior. By utilizing the spin Seebeck effect (SSE) in YIG, we measured the temperaturedependent (T-dependent) inverse spin Hall-effect (ISHE) voltage of $Cu_{1-x}Mn_x$ alloys. Crucially, for each composition, a voltage peak (T_p) was observed, and it exhibited almost identical composition dependence as that of T_f , thus revealing a strong correlation between T_p and T_f . A similar behavior was also captured using the SG insulator, amorphous YIG (a-YIG). Further, we demonstrated that all results followed a universal curve in a scaling plot based on spin susceptibility, which agreed with the three-dimensional (3D) Ising model and supported the finding of a strong short-range correlation during spin fluctuation. Thus, examining spin-current injection and spin-to-charge conversion is a simple, viable, and convenient means of electrically investigating the complex spin-freezing process in magnetically short-range ordered SG materials. Similarly, the SSE was also recently used to investigate the short-range magnetic order in frustrated magnetic Gd₃Ga₅O₁₂, discovered recently by [14].

II. EXPERIMENT

We used magnetron cosputtering to deposit thin films of $Cu_{1-x}Mn_x$ alloys onto polycrystalline YIG substrates. To prevent oxidation, a 2-nm-thick Al_2O_3 layer was deposited

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FIG. 1. (a) Schematic of the magnetic ordering from spin glass to the antiferromagnetic state by increasing composition of Mn and from the magnetically ordered state to the spin-fluctuation state by increasing temperature. Schematic of the spin-current transmission through (b) SG metal and (c) SG insulator using the ISHE/SSE measurement.

to be the top layer. The composition of the $Cu_{1-x}Mn_x$ films was precisely determined using the electron probe x-ray microanalyzer. For magnetization measurement, we fabricated 300-nm-thick $Cu_{1-x}Mn_x$ on oxidized Si substrates. For ISHE/SSE measurement, 5- to 100-nm-thick $Cu_{1-x}Mn_x$ films were prepared. In addition, 1- to 300-nm-thick *a*-YIG thin films were deposited at room temperature on the oxidized Si and YIG slab through rf sputtering.

III. RESULTS AND DISCUSSION

The *T*-dependent ZFC and FC magnetization of $Cu_{1-x}Mn_x$ were measured using a superconducting quantum interference device. In the ZFC process, the sample was cooled to 5 K without using an external magnetic field. Then, magnetization was measured by raising the temperature to 300 K under 100 Oe. In the FC process, the sample was cooled from 300 to 5 K under the magnetic field, and the magnetization was measured with the same field. A pronounced cusp, corresponding to T_f and featuring the canonical SG behavior [15], was observed for 14 and 34% Mn at 45 and 67 K, respectively, as depicted in Fig. 2(a). For 54.3 and 79.4% Mn, the ZFC peak was broader and the bifurcation occurred at a higher temperature. This was possibly because of the mixing of the short-range and long-range orderings [15]. Because irreversibility is a distinctive feature of SG materials, we recorded temperatures at bifurcation as T_f , and these temperatures were 100 and 160 K for 54.3 and 79.4% Mn, respectively. For pure Mn, the ZFC peak at 90 K was consistent with its Néel temperature (T_N ; for simplicity, we use T_f hereafter) [16]. Therefore, an increase in Mn content resulted in an increase in T_f , reaching a maximum at x = 79.4%, and then a decrease.

We next measured the ISHE/SSE voltage for these samples. In ISHE/SSE measurement, the sample was placed between the resistance heater and the Cu block (heat sink) to generate a temperature gradient along the z axis, and the voltage was measured along the y axis under an external field along the x axis, as depicted in Fig. 1(a) [17,18]. We first present the spin-dependent thermal voltages for SG



FIG. 2. (a) ZFC (dashed curve) and FC (solid curve) temperature-dependent magnetization for $\text{Cu}_{1-x}\text{Mn}_x(300)/\text{Si}$ with x = 0.14 (black), 0.34 (red), 0.54 (green), 0.79 (blue), and 1 (yellow). Arrows indicate the corresponding spin-freezing temperature (T_f) for each composition. (b) Field-dependent ISHE voltage for Cu₈₆Mn₁₄(5)/YIG (upper red), Cu₈₆Mn₁₄(5)/Si (upper black), Mn(5)/YIG (lower red), and Mn(5)/Si (lower black) at room temperature.

Cu₈₆Mn₁₄(5)/YIG and AFM Mn(5)/YIG (numbers in parentheses are thicknesses in nanometers) in Fig. 2(b). Compared with Cu₈₆Mn₁₄/YIG with $|V_{ISHE}| = 0.5 \,\mu$ V, a larger value of approximately $7 \,\mu$ V was observed in Mn/YIG. In the low-field region, a plateau behavior was observed because of noncollinear YIG surface magnetization [19]. The controlled samples, Cu₈₆Mn₁₄(5)/Si and Mn(5)/Si, exhibited no measurable thermal voltages; thus, the contribution of anomalous Nernst effect was not present in these films. Notably, the V_{ISHE} of Cu₈₆Mn₁₄/YIG had an opposite sign to that of Mn/YIG. The sign of ϑ_{SH} for binary alloys depends on the effective number of their valence electrons. This is discussed later.

Spin-current enhancement during spin-freezing transition is captured by the *T*-dependent V_{ISHE} of SG Cu₈₆Mn₁₄/YIG with various thicknesses. As depicted in Fig. 3(a), $|V_{ISHE}|$ first increased, reaching a maximum of approximately $T_p = 90$ K and revealing the influence of SF, and then decreased along with temperature. Notably, T_p was not equal to T_f but was approximately two times larger, as depicted in Fig. 3(c). T_f and T_p were observed on 300- and 5-nm-thick films, respectively. According to finite-size scaling theory, the 5-nm film could have lower T_f than 300-nm film, as indicated in the following expression [20,21]:

$$\frac{T_f(\infty) - T_f(t)}{T_f(\infty)} = \left(\frac{\xi_0}{t}\right)^{\lambda} \tag{1}$$

Here, $T_f(\infty)$ is the bulk spin-freezing (or Néel for antiferromagnet) temperature, *t* is the thickness, $\lambda = 0.75$ is the shift exponent, and $\xi_0 = 3.52$ nm is the spin-correlation length, obtained from Refs. [21,22]. Therefore, after considering the finite-size effect, we obtained a T_f (5 nm) of approximately 11 K, which was approximately nine times smaller than the T_p for the same thickness. The considerable



FIG. 3. (a) Temperature-dependent spin Seebeck coefficient for 5-nm- (black), 8-nm- (red), and 15-nm-thick (blue) $Cu_{86}Mn_{14}$. (b) Temperature-dependent spin Seebeck coefficient for $Cu_{1-x}Mn_x$ with x = 0.14 (black), 0.34 (red), 0.54 (green), 0.79 (blue), and 1 (yellow). Arrows indicate the voltage peak at T_p . (c) Plots of T_p (green star), T_f (red triangle), and T_p/T_f (yellow square) on $Cu_{1-x}Mn_x$ compositions.

difference in T_p and T_f was not entirely unexpected. Studies on SG that used the neutron spin echo, Mossbauer effect, and muon spin-relaxation techniques have reported that the onset of the complex spin-freezing process is considerably higher than T_f [9,23,24]. The approximate ratio of T_p/T_f (5 nm) obtained in our study was 9, which is consistent with these reports and indicates that the maximum SF in SG occurs at a temperature considerably higher than T_f . Compared with the aforementioned sophisticated techniques, the proposed method is a considerably simple and convenient electrical method for investigating the complex spin-freezing transition in SG.

Similar enhancement was also obtained for other compositions, as depicted in Fig. 3(b). For $Cu_{1-x}Mn_x$ alloys with $x = 14, 34, 54, 79, and 100, T_p$ was 90, 140, 160, 210, and 170 K, respectively, demonstrating an increasing trend followed by a decrease. The T-dependent ISHE/SSE behavior in Pt/YIG was attributed to the competition between magnon propagation length and the concentration of magnon in YIG [25]. However, the composition-dependent T_p observed in our study clearly indicated that the magnonic spin current was strongly modulated by the SF in $Cu_{1-x}Mn_x$ alloys. Furthermore, although T_f and T_p presented almost identical composition dependence, T_p was always larger (1.3–2.1 times) than T_f in the compositions, as depicted in Fig. 3(c). Considering the finite-size effect, this ratio could be even larger. In addition, the T_p for Cu₈₆Mn₁₄ was almost thickness independent, as illustrated in Fig. 3(a). This was because the film thickness was larger than the spin-correlation length ξ_0 .

We used critical theory to understand the continuous phase transition in Cu_{1-x}Mn_x [26]. In critical theory, the magnetic susceptibility χ follows the relation $\frac{\chi}{ft^{\gamma}} = \frac{h}{t^{\gamma+\beta}}$, where $h = \frac{H}{k_{\rm B}T}$, β and γ are the critical exponents for spontaneous



FIG. 4. Scaling plot of the normalized spin Seebeck coefficient by the 3D Ising critical exponent with (a) $T_{\text{critical}} = T_p$ and (b) $T_{\text{critical}} = T_f$ for Cu_{1-x}Mn_x over the entire range of compositions.

staggered magnetization, $t = \frac{T - T_{\text{critical}}}{T_{\text{critical}}}$ is the reduced temperature for $T > T_{\text{critical}}$, and f is the scaling function. A previous study [27] showed that the spin Seebeck coefficient (*S*) scales with magnetic susceptibility at temperatures higher than the AFM transition temperature. For SG, similarly, we plotted $\frac{|S|}{|S_{\max}|^{1/\gamma}}$ versus $\frac{h}{t^{\gamma+\beta}}$, as depicted in Fig. 4, where *S* is normalized by dividing its peak value $|S_{\max}|$. For $T_{\text{critical}} = T_p$, data collapse onto a single curve, but for $T_{\text{critical}} = T_f$, data diverge at temperatures close to T_{critical} , as depicted in Figs. 4(a) and 4(b), respectively. Therefore, our analysis demonstrated that *S* scales with spin susceptibility better than with the magnetic susceptibility and T_p obtained from the SSE measurement represents the critical point of spin susceptibility during the continuous phase transition.

In addition, we calculated ϑ_{SH} and spin-diffusion length (λ_{SD}) for canonical SG Cu₈₆Mn₁₄ and AFM Mn by fitting the thickness (*t*)-dependent electrical resistivity (ρ) and V_{ISHE} using Eq. (2) [28,29]:

$$\Delta V_{\rm ISHE}(t) = 2CL\nabla T \rho(t)\theta_{\rm SH}\frac{\lambda_{\rm sd}}{t} \tanh\left(\frac{t}{2\lambda_{\rm sd}}\right) \qquad (2)$$

Here, L = 4 mm is the distance between the voltage terminals, $\nabla T = 12 \text{ K/mm}$ is the temperature gradient, and C is the spin-current injection coefficient. We use $C(Mn) = 3.5 \text{ Am}^{-1} \text{ K}^{-1}$ for Mn [30] and $C(Cu_{86} Mn_{14}) = 1.5 Am^{-1} K^{-1}$ for $Cu_{86}Mn_{14}$ [31]. From the fitting in Figs. 5(a) and 5(b), we obtained $\theta_{\rm SH}({\rm Cu}_{86}{\rm Mn}_{14}) = 6.94 \pm 1.33\%, \theta_{\rm SH}({\rm Mn}) = -3.70 \pm 1.5\%,$ $\lambda_{SD}(Cu_{86}Mn_{14}) = 6.36 \pm 1.85 \text{ nm}, \text{ and } \lambda_{SD}(Mn) = 2.89 \pm 1.85 \text{ nm}$ 1.35 nm. Because Cu has negligible θ_{SH} , the large θ_{SH} in 14% Mn-doped Cu with an opposite sign to pure Mn was notable. We further measured ΔV_{ISHE} for 5-nm-thick $\text{Cu}_{1-x}\text{Mn}_x$ over the entire composition. As depicted in Fig. 5(d), ρ increased linearly with x. We plot $\Delta V_{\rm ISHE}/\rho$ versus composition in Fig. 5(c) because it is proportional to θ_{SH} . When adding Mn into Cu, $\Delta V_{\rm ISHE}/\rho$ gradually increased and reached the positive maximum at x = 34%, then decreased and crossed zero at approximately x = 60%; it finally reached the negative maximum at x = 100%, as depicted in Fig. 5(c). For a single 3d transition metal, when the total number of valence 3d and 4s electrons (n_{3d+4s}) is smaller (larger) than 8–9, the sign of $\theta_{\rm SH}$ is positive (negative) [31]. This criterion also works for binary alloys. The effective n_{3d+4s} for $Cu_{1-x}Mn_x$ alloy is as follows:

$$n_{3d+4s}(Cu_{1-x}Mn_x) = 11 \times (1-x) + 7 \times x = 11 - 4x.$$
 (3)



FIG. 5. Thickness-dependent $|\Delta V_{\text{ISHE}}|/\rho$ for (a) Cu₈₆Mn₁₄ (*t*)/YIG and (b) Mn(*t*)/YIG. Red dashed line is the fitting curve determined by Eq. (2). Plot of (c) $|\Delta V_{\text{ISHE}}|/\rho$ and (d) resistivity as a function of Cu_{1-x}Mn_x composition.

According to the empirical criterion, θ_{SH} changes sign at $n_{3d+4s} = 8 - 9$, corresponding to x = 0.5 - 0.75, and is consistent with our result (*x* is approximately 0.6). We thus confirmed that the effective total number of 3*d* and 4*s* valence electrons is crucial in tuning and determining the sign of θ_{SH} for binary alloys.

In addition to the conducting SG, we studied the spincurrent enhancement in the insulating SG *a*-YIG, which possesses strong local negative exchange interaction but exhibits no long-range order, resulting in SG-like behavior. We fabricated *a*-YIG(300)/Si and determined its T_f to be 50 K from the ZFC and FC curves under 1 T, as depicted in Fig. 6(a). The insertion of *a*-YIG between Pt and YIG enables the



FIG. 6. (a) Temperature-dependent magnetization under ZFC (black) and FC (red) for *a*-YIG(300)/Si. (b) Field-dependent V_{ISHE} for Pt/*a*-YIG(*t*)/YIG. (c) Normalized V_{ISHE} for Pt/*a*-YIG(*t*)/YIG as a function of *a*-YIG thicknesses. Inset depicts normalized V_{ISHE} for Pt/SiO₂(*t*)/YIG as a function of SiO₂ thicknesses. Red curves are fittings from Eq. (4). (d) Temperature-dependent spin Seebeck coefficient for Pt(3)/YIG (red), Pt(5)/YIG (yellow), and Pt(3)/*a*-YIG(*t*)/YIG with *t* = 0 (red), 5 (green), and 10 nm (blue).

spin-current transmission through an SG insulator to be detected by measuring the ISHE/SSE. Notably, although a conventional insulating layer, such as SiO₂ or MgO at thickness of only a few nanometers, readily blocked the spin current, V_{ISHE} was still detectable in Pt/a-YIG (t)/YIG even when the a-YIG layer was as thick as 10 nm at 300 K, as depicted in Fig. 6(b). We extracted the λ_{SD} using the following simple estimation equation:

$$V_{\rm ISHE}(t)/V_{\rm ISHE}(0) = Ae^{-t/\lambda_{\rm SD}}$$
(4)

where A is a constant and t is the thickness of the a-YIG layer. The $\lambda_{SD}(a$ -YIG) was approximately 4.5 nm and considerably longer than $\lambda_{SD}(SiO_2) = 0.06$ nm, as depicted in Fig. 6(c), but considerably shorter than the recently reported micrometer-long spin transmission distance in a-YIG determined from nonlocal measurement [32]. We measured the T-dependent V_{ISHE} for Pt/YIG and Pt/a-YIG(t)/YIG, as depicted in Fig. 6(d). The T_p of Pt(3)/YIG was 100 K and that of Pt(3)/a-YIG(5)/YIG is much higher at around 150 K. For 10-nm a-YIG, the signal was considerably suppressed with a markedly broader peak. Nevertheless, T_p was still higher than T_f for Pt/a-YIG/YIG, which was consistent with that for $Cu_{1-x}Mn_x/YIG$ and indicated that the maximum SF in the insulating SG occurs at a temperature considerably higher than its magnetic transition temperature. Thus, we demonstrated the use of SSE evaluates the change of spin susceptibility during spin-freezing transition in both conducting and insulating SGs.

IV. CONCLUSION

We studied the complex spin-freezing process through injecting spin current into the conducting SG $Cu_{1-x}Mn_x$ alloy. For each composition, we obtained T_f and observed the pronounced enhancement in the T-dependent ISHE voltage with a peak at T_p . We demonstrated that T_p has a strong correlation with T_f because of almost identical composition dependence. Crucially, we provided direct evidence that the strongest spin fluctuation occurs at a temperature considerably higher than the magnetic critical temperature, which could be attributed to the long and complex spin-freezing process. Furthermore, we demonstrated that SSE measures the spin susceptibility during the spin-freezing process. A similar behavior was observed in the SG-like *a*-YIG insulator, thus demonstrating the versatility of this method. In addition, by estimating θ_{SH} in Cu_{1-x}Mn_x, we confirmed the importance of the effective number of valence electrons in ISHE. The proposed approach utilizing the spin current is not only a promising alternative in studying the spin-freezing transition for SG but also may enable energyefficient spintronic applications using SG materials.

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